Silicon P Channel MOS FET High Speed Power Switching

# HITACHI

ADE-208-580B (Z) 3rd. Edition June 1, 1998

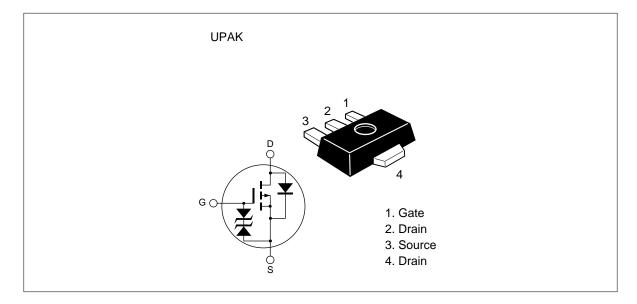
#### Features

Low on-resistance

 $R_{\text{DS(on)}}$  = 0.35  $\Omega$  typ. at (V  $_{\text{GS}}$  = -10V,  $I_{\text{D}}$  = -1A)

- Low drive current
- 4 V gate drive devices
- High speed switching

#### Outline



### **Absolute Maximum Ratings** (Ta = 25°C)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V <sub>DSS</sub>	-60	V	
Gate to source voltage	V <sub>GSS</sub>	±20	V	
Drain current	I <sub>D</sub>	-2	A	
Drain peak current	Note1 D(pulse)	-4	A	
Body-drain diode reverse drain current	I <sub>DR</sub>	-2	А	
Avalanche current	AP Note2	-2	A	
Avalanche energy	E <sub>AR</sub>	0.34	mJ	
Channel dissipation	Pch Note3	1	W	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Note: 1.  $PW \le 10\mu s$ , duty cycle  $\le 1 \%$ 

2. value at Tch =  $25^{\circ}$ C, Rg  $\geq 50 \Omega$ 

3. Value at when using the aluminaceramic board (12.5x20x0.7mm)

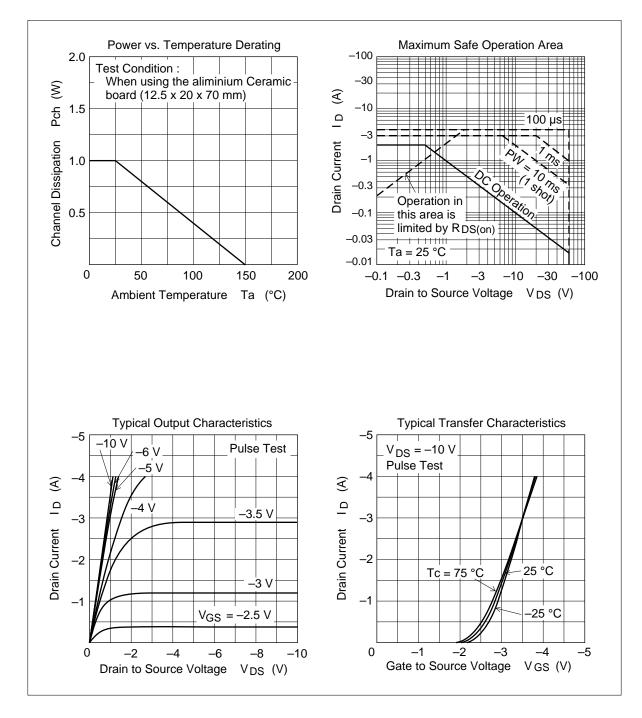
#### **Electrical Characteristics** (Ta = 25°C)

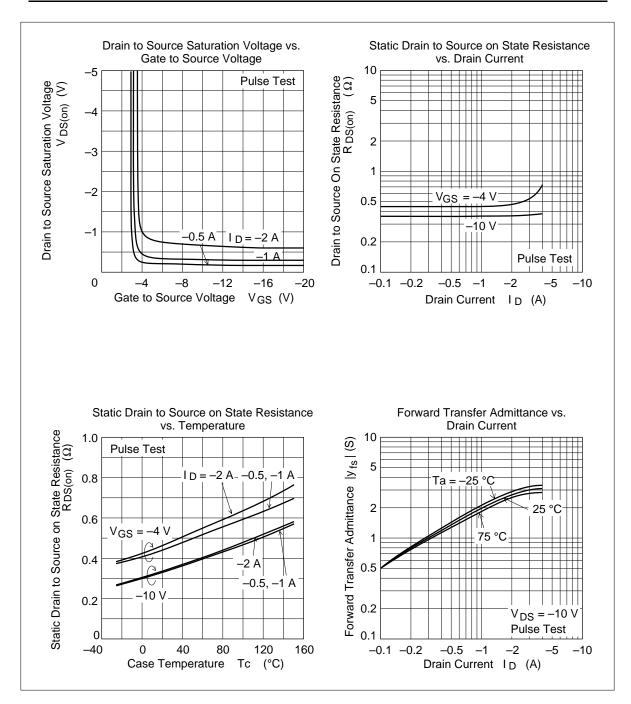
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	V <sub>(BR)DSS</sub>	-60	_	_	V	$I_{\rm D} = -10 {\rm mA}, V_{\rm GS} = 0$
Gate to source breakdown voltage	V <sub>(BR)GSS</sub>	±20			V	$I_{g} = \pm 100 \mu A, V_{DS} = 0$
Zero gate voltege drain current	I <sub>DSS</sub>			-10	μA	$V_{\rm DS} = -60 \text{ V}, V_{\rm GS} = 0$
Gate to source leak current	I <sub>GSS</sub>			±10	μA	$V_{GS} = \pm 16V, V_{DS} = 0$
Gate to source cutoff voltage	V <sub>GS(off)</sub>	-1.0		-2.0	V	$I_{\rm D} = -1$ mA, $V_{\rm DS} = -10$ V
Static drain to source on state	R <sub>DS(on)</sub>		0.35	0.46	Ω	$I_{\rm D} = -1A, V_{\rm GS} = -10V^{\rm Note4}$
resistance	R <sub>DS(on)</sub>		0.45	0.63	Ω	$I_D = -1A$ , $V_{GS} = -4V^{Note4}$
Forward transfer admittance	y <sub>fs</sub>	1.2	2.0		S	$I_{\rm D} = -1A, V_{\rm DS} = -10V^{\rm Note4}$
Input capacitance	Ciss		220		pF	$V_{DS} = -10V$
Output capacitance	Coss		110	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss		35		pF	f = 1MHz
Turn-on delay time	t <sub>d(on)</sub>		10		ns	$V_{GS} = -10V, I_{D} = -1A$
Rise time	t,		11	_	ns	$R_L = 30\Omega$
Turn-off delay time	t <sub>d(off)</sub>		45		ns	
Fall time	t <sub>f</sub>		30		ns	
Body-drain diode forward voltage	V <sub>DF</sub>	_	-1.05		V	$I_{\rm D} = -2A, V_{\rm GS} = 0$
Body–drain diode reverse recovery time	t <sub>rr</sub>		50		ns	$I_F = -2A$ , $V_{GS} = 0$ diF/ dt = 50A/µs

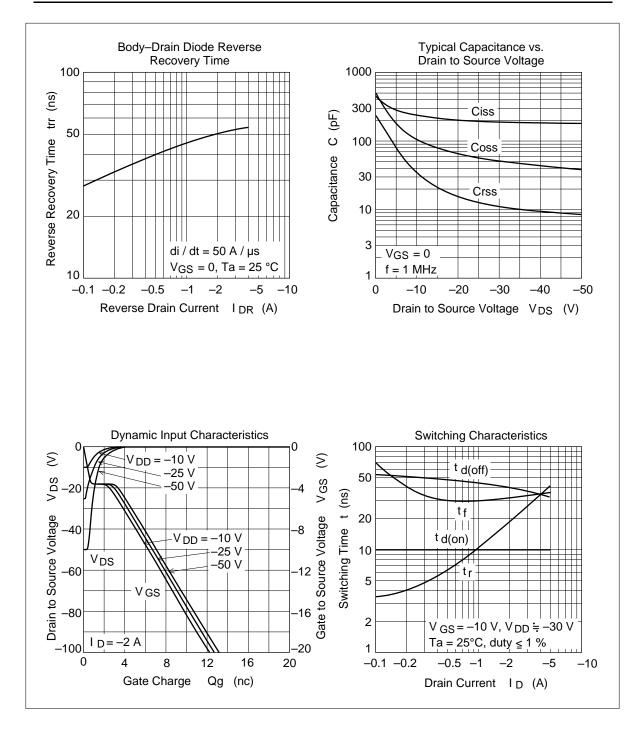
Note: 4. Pulse test

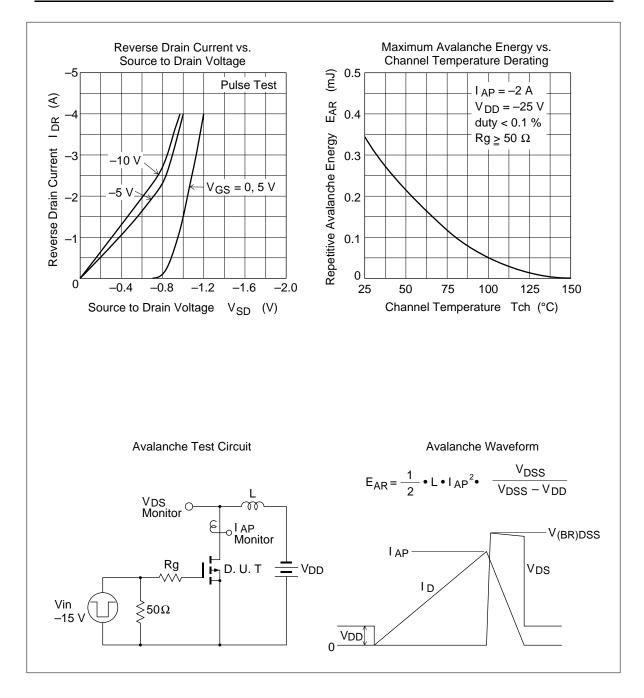
5. Marking is "AZ"

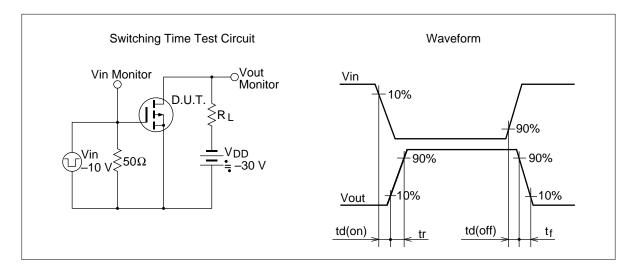
#### **Main Characteristics**



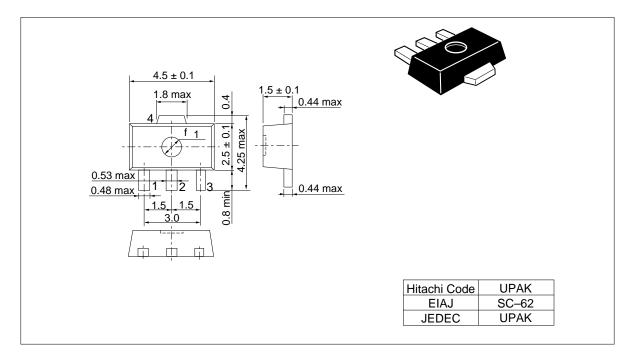








#### Package Dimensions (Unit: mm)



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# HITACHI

#### Hitachi, Ltd.

Semiconductor & IC Div. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100, Japan Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

#### For further information write to:

Hitachi America, Ltd. Semiconductor & IC Div. 2000 Sierra Point Parkway Brisbane, CA. 94005-1835 U S A Tel: 415-589-8300 Fax: 415-583-4207 Hitachi Europe GmbH Electronic Components Group Continental Europe Dornacher Straße 3 D-85622 Feldkirchen München Tel: 089-9 91 80-0 Fax: 089-9 29 30 00 Hitachi Europe Ltd. Electronic Components Div. Northern Europe Headquarters Whitebrook Park Lower Cookham Road Maidenhead Berkshire SL6 8YA United Kingdom Tel: 0628-585000 Fax: 0628-778322 Hitachi Asia Pte. Ltd. 16 Collyer Quay #20-00 Hitachi Tower Singapore 0104 Tel: 535-2100 Fax: 535-1533

Hitachi Asia (Hong Kong) Ltd. Unit 706, North Tower, World Finance Centre, Harbour City, Canton Road Tsim Sha Tsui, Kowloon Hong Kong Tel: 27359218 Fax: 27306071

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